Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination , _
10/562,740	BORTHWICK ET AL.
Examiner	Art Unit

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415	181, 191, 192, 208.1, 208.2	12/31/2007	cv
415	209.4	12/31/2007	cv
415	210.1	12/31/2007	cv
415	211.2	12/31/2007	cv
416	223A, 238	12/31/2007	cv
416	242, 243	12/31/2007	cv
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